



# JUNCTION FIELD EFFECT TRANSISTOR **2SK3230**

# N-CHANNEL SILICON JUNCTION FIELD EFFECT TRANSISTOR FOR IMPEDANCE CONVERTER OF ECM

# DESCRIPTION

The 2SK3230 is suitable for converter of ECM.

#### FEATURES

- Compact package
- High forward transfer admittance 1000 μS TYP. (IDSS = 100 μA) 1600 μS TYP. (IDSS = 200 μA)
- Includes diode and high resistance at G S

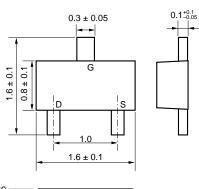
#### **ORDERING INFORMATION**

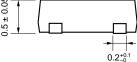
PART NUMBER	PACKAGE		
2SK3230	SC-89 (TUSM)		

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

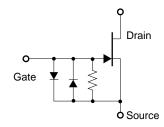
Drain to Source Voltage Note1	VDSX	20	V
Gate to Drain Voltage	Vgdo	-20	V
Drain Current	lo	10	mA
Gate Current	lg	10	mA
Total Power Dissipation Note2	Рт	200	mW
Junction Temperature	Tj	125	°C
Storage Temperature	Tstg	-55 to +125	°C

# PACKAGE DRAWING (Unit: mm)





#### EQUIVALENT CIRCUIT



#### **Notes 1.** Vgs = -1.0 V

2. Mounted on ceramic substrate of 3.0 cm<sup>2</sup> x 0.64 mm

Remark Please take care of ESD (Electro Static Discharge) when you handle the device in this document.

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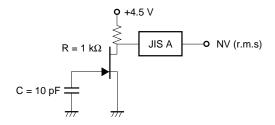
# ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Cut-off Current	IDSS	$V_{DS} = 5.0 V, V_{GS} = 0 V$	40		600	μA
Gate Cut-off Voltage	V <sub>GS(off)</sub>	$V_{DS} = 5.0 \text{ V}, \text{ ID} = 1.0 \ \mu\text{A}$	-0.1		-1.0	V
Forward Transfer Admittance	y <sub>fs1</sub>	$V_{DS} = 5.0 \text{ V}, \text{ ID} = 30 \ \mu\text{A}, \text{ f} = 1.0 \text{ kHz}$	350			μS
Forward Transfer Admittance	yfs2	$V_{DS} = 5.0 V, V_{GS} = 0 V, f = 1.0 \text{ kHz}$	350			μS
Input Capacitance	Ciss	$V_{DS} = 5.0 V, V_{GS} = 0 V, f = 1.0 MHz$		7.0	8.0	pF
Noise Voltage	NV	See Test Circuit		1.8	3.0	μV

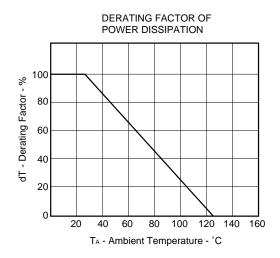
#### IDSS RANK

MARKING	J2	J3	J4	J5	J6	J7
loss (μA)	40 to 70	60 to 110	90 to 180	150 to 300	200 to 450	300 to 600

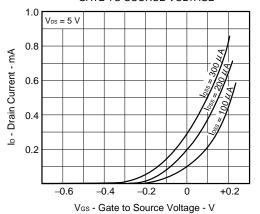
# NOISE VOLTAGE TEST CIRCUIT

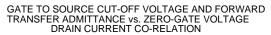


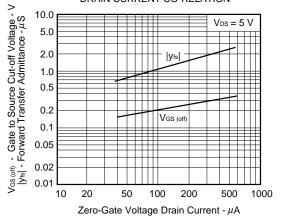
### TYPICAL CHARACTERISTICS (TA = 25°C)

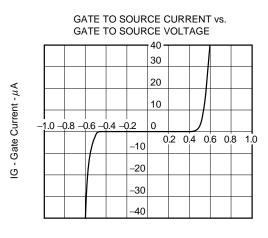






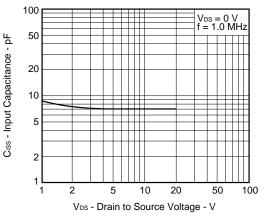


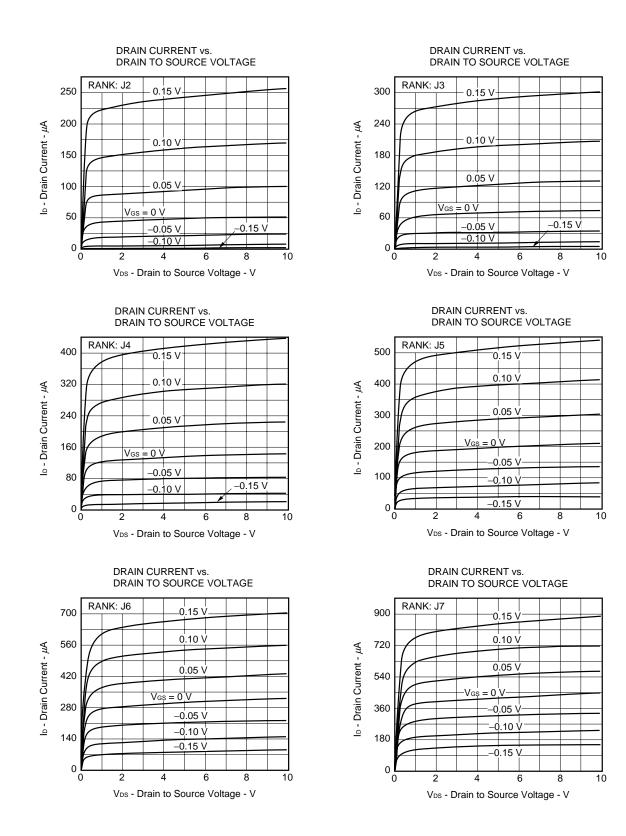




VGS - Gate to Source Voltage - V

INPUT CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE





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